

Rev. A1

PDL 2P PLUG HSG AND CAP HSG 3.96 NAT

1. INTRODUCTION

1.1 Purpose

Testing was performed on PDL 2P PLUG HSG AND CAP HSG 3.96 NAT to determine its conformance to the customer requirements.

1.2 Scope

This report covers the Glow Wire Test performance of PDL 2P PLUG HSG AND CAP HSG 3.96 NAT. Testing was performed at the Shanghai Electrical Components Test Laboratory between Apr.29 and Apr.30, 2014. The associated test number is TP-14-00698.

1.3 Conclusion

Based on the test results, all meet the requirement according to IEC 60335-1, 2004, and IEC 60695-2-11, 2000.

1.4 Test Specimens

Specimens with the following part numbers were used for test:

Test request No.	' SI NO I HOUSING P/N I POSITION I UTV I Part Description		Material			
TP-14-00698	1	2005247-1	2 Pos	10	PDL 2P PLUG HSG 3.96(GWT) NAT	PA66
17-14-00096	2	2005248-1	2 Pos	10	PDL 2P CAP HSG 3.96 F/H(GWT) NAT	(1573789-1)

TP-14-00698 consist of each 10pcs Plug Housing samples and Cap housing samples for SI No. 1, 2. See Fig 1, Fig 2.



Plug Housing (Fig.1)

Cap housing (Fig 2)

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1.5 Test Sequence

	Test Group (a)			
Test Item	1			
	Test Sequence(b)			
Visual examination	1			
Glow Wire Test	2			
Sample Size	10x2			

Note: a). Test group defined per customer requirement. b). Numbers indicate sequence in which tests are performed.

1.6 Environmental Conditions

Unless otherwise stated, the following environmental conditions prevailed during testing:

Temperature:	15°C to 35°C
Relative Humidity:	25% to 75%

2. TEST PROCEDUES

2.1. Visual examination

All specimens were visually examined for evidence of physical damage detrimental to product performance (Visually inspected under a stereomicroscope, at a 10x magnification, with suitable illumination). Test method: IEC 60512-1-1, Test 1a.

2.2. Glow wire Test

Thermal stabilization of specimens: 24 h at 15-35 °C and 45-75%RH. Test condition: The extremity of the wire is positioned horizontally and brought into contact with the sample wit a force between 0.8 and 1.2N for a period of 30s. Test temperature: 750°C, Time of Glow tip application Ta: 30s Requirements: No flame or Te-Ti≤2s. Test Method: IEC 60335-1, 2004, and IEC 60695-2-11, 2000.

3. SUMMARY OF TESTING

3.1. Initial Examination of Product

All group specimens were visually examined and no evidence of physical damage detrimental to product performance was observed.



3.2. Glow wire Test Glow wire test result see Tab.1, 2,

Group	Number of data points	Condition	Point of glow tip application	Ti (sec)	Te (sec)	Flame Height (mm)	Drops (yes/no)	Light tissue paper burns (yes/no)	Judgment
		Final 10 (GWT 750°C)	A1	0	0	0	no	no	Meet spec
			A2	0	0	0	no	no	Meet spec
			A3	0	0	0	no	no	Meet spec
PDL 2P			A4	0	0	0	no	no	Meet spec
PLUG HSG			A5	0	0	0	no	no	Meet spec
3.96 NAT	10		A6	0	0	0	no	no	Meet spec
(2005247-1)			A7	0	0	0	no	no	Meet spec
			A8	0	0	0	no	no	Meet spec
			A9	0	0	0	no	no	Meet spec
			A10	0	0	0	no	no	Meet spec

Tab 1

Group	Number of data points	Condition	Point of glow tip application	Ti (sec)	Te (sec)	Flame Height (mm)	Drops (yes/no)	Light tissue paper burns (yes/no)	Judgment
		Final (GWT	A1	0	0	0	no	no	Meet spec
			A2	0	0	0	no	no	Meet spec
			A3	0	0	0	no	no	Meet spec
PDL 2P CAP			A4	0	0	0	no	no	Meet spec
HSG 3.96			A5	0	0	0	no	no	Meet spec
NAT	10		A6	0	0	0	no	no	Meet spec
(2005248-1)	750°C)	A7	0	0	0	no	no	Meet spec	
			A8	0	0	0	no	no	Meet spec
			A9	0	0	0	no	no	Meet spec
			A10	0	0	0	no	no	Meet spec

Tab 2



Samples picture after test, see Fig 3, Fig 4.

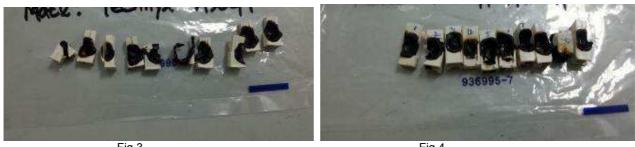


Fig 3

Fig 4

4. CALIBRATION

4.1 Calibration Statement

All equipment containing a calibration number is calibrated and traceable through TE Connectivity (TE).

Ν	lo.	Test Item	Equipment Code	Equipment application	Calibration Effective Period	Serial No.
	1	Examination of Product	1	Visual observation	1	1
	2	Glow Wire Test	Glow wire Tester	Glow Wire 750Cdegree Test	2015/05/17	LAB-T012

5. VALIDATION

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